

Contents

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|--|----|
| Vacuum Ultraviolet Smoothing of Nanometer-Scale Asperities of Poly(methyl methacrylate) Surface <i>R. V. Lapshin, A. P. Alekhin, A. G. Kirilenko, S. L. Odintsov, and V. A. Krotkov</i> | 1 |
| Electron-Energy Characteristics and the Spectrum of One-Electron States of the Surfaces of Ferric and Nickel Oxides with Fluoropolymer Coatings <i>A. O. Litinskii, S. I. Novikov, and M. V. Petrov</i> | 12 |
| The Study of the Bolometric Response of Detector Elements Based on Nanostructured HTSC-Films <i>S. V. Antonenko, D. P. Korotkov, A. S. Mairapetyan, V. S. Kharitonov, and S. M. Tolkacheva</i> | 19 |
| Mathematical Model of Thermocracking of Anisotropic Brittle Materials <i>P. D. Gindin</i> | 22 |
| Elimination of the Background Nonuniformity of the Experimental Contrast of Single-Crystal Structural Defects <i>V. A. Tkal', M. N. Petrov, N. A. Voronin, and I. V. Dzyuba</i> | 25 |
| X-Ray Diffraction Study of Silicon Single Crystals Highly Doped with Boron <i>I. L. Shul'pina, S. S. Rouvimov, and R. N. Kyutt</i> | 32 |
| Properties of Misfit Dislocations and Pseudodislocations Not Typical For Defects of Homogeneous Crystals <i>E. M. Trukhanov</i> | 36 |
| Method To Determine the Interface's Fractal Dimensions of Metal-Semiconductor Electric Contacts from Their Static Instrumental Characteristics <i>N. A. Torkhov</i> | 45 |
| Secondary Emission of Carbon Ions from Graphite Nanocrystallites <i>K. F. Minnebaev, Yu. A. Ryzhov, I. I. Shkarban, and V. E. Yurasova</i> | 59 |
| Surface Micromorphology of CdTe(310) Layers Grown by Molecular Beam Epitaxy <i>M. V. Yakushev, D. V. Brunev, and Yu. G. Sidorov</i> | 64 |
| Features of Photosensitive Polycrystalline PbCdSe Layers with a Network-like Structure <i>Yu. M. Spivak and V. A. Moshnikov</i> | 71 |
| Electron Microscopy Studies of Organic Matter in Rocks <i>N. A. Skibitskaya, V. A. Kuzmin, and A. V. Garshev</i> | 77 |
| Study of the Surface Microrelief of the Titanium VT18u Alloy after Electrochemical Dimensional Processing <i>V. P. Stroshkov and I. G. Grigorov</i> | 81 |
| Description of the Line Shape of Bragg Peak in Neutron Powder Diffractometers Taking into Account Spatial Effects <i>V. I. Bobrovskii</i> | 87 |
| Formation and Destruction of Polyelectrolyte Microcapsules Modified by Rhodamine 6G <i>I. V. Marchenko, G. S. Plotnikov, A. N. Baranov, A. M. Saletskii, and T. V. Bukreeva</i> | 95 |

| | |
|--|-----|
| Preliminary Characterization of Semiconductor Detectors in the Soft X-Ray Range Using Synchrotron Radiation from the VEPP-4 Storage Ring <i>P. N. Aruev, Yu. M. Kolokolnikov, N. V. Kovalenko, A. A. Legkodymov, V. V. Lyakh, A. D. Nikolenko, V. F. Pindyurin, V. L. Sukhanov, and V. V. Zabrodsky</i> | 99 |
| X-ray Diagnostics of Semiconductor Heterostructures: Some Achievements and Perspectives for Development <i>R. M. Imamov and I. A. Subbotin</i> | 104 |
| Kinetic of Poly(Vinylidene Fluoride) Defluorination under X-ray Irradiation <i>A. M. Kuvshinov, S. S. Chebotaryov, L. A. Pesin, I. V. Gribov, N. A. Moskvina, V. L. Kuznetsov, S. E. Evsyukov, T. S. Sapozhnikova, and A. A. Mirzoev</i> | 122 |
| Annealing Atmosphere Effect on the Processes of Recrystallization of Polycrystalline Films of Cadmium Selenide <i>B. N. Levonovich</i> | 128 |
| Study of Thin Ge Films with Amorphous and Nanocrystalline Phases via the Techniques of EXAFS Spectroscopy and AFM <i>R. G. Valeev, A. N. Deev, D. V. Surnin, V. V. Kriventsov, O. V. Karban', V. M. Vetoshkin, and O. I. Pivovarova</i> | 136 |
| Structure and Properties of Copper Coatings Electrodeposited under X-Ray Radiation <i>V. M. Anishchik, N. G. Val'ko, V. V. Voina, and A. S. Vorontsov</i> | 142 |
| Method for Edge Contour Extraction of a Scanning Probe Microscope Image <i>D. V. Khlopov, O. V. Karban, M. V. Telegina, O. M. Nemtsova, I. V. Zhurbin, and A. V. Smurygin</i> | 146 |
| Characterization of Epitaxial <i>n</i> -GaP/ <i>p</i> -PSi Heterojunctions <i>A. Ashery, M. A. Salem, and G. A. El-Shobaky</i> | 152 |
| On the Effect of Electric Potential on Resistance of Metals' Surface to Microindentation <i>V. I. Danilov, L. B. Zuev, S. V. Konovalov, R. A. Filip'ev, B. S. Semukhin</i> | 157 |
| Peculiarities of Induced Radiation and Controlled Dechanneling of Relativistic Particles in Crystals under the Cherenkov–Vavilov Extreme Condition <i>V. I. Vysotskii and M. V. Vysotskii</i> | 162 |
| The Region of Gallium Solubility in Lead Telluride Films Grown on Silicon Substrates <i>S. V. Belenko, E. A. Dolgoplova, A. M. Samoilo, Yu. V. Synorov, and M. K. Sharov</i> | 170 |
| Heat Transfer under Heating of a Surface with Artificial Submillimeter Roughness <i>L. A. Fomenko and L. G. Lovtsova</i> | 179 |
